

HUF75842P3, HUF75842S3SS

Electrical Specifications $T_C = 25^{\circ}\text{C}$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS	
OFF STATE SPECIFICATIONS							
Drain to Source Breakdown Voltage	BV _{DSS}	I _D = 250μA, V _{GS} = 0V (Figure 11)	150	-	-	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 140V, V _{GS} = 0V	-	-	1	μA	
		V _{DS} = 135V, V _{GS} = 0V, T _C = 150 ⁰ C	-	-	250	μA	
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±20V	-	-	±100	nA	
ON STATE SPECIFICATIONS							
Gate to Source Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 250μA (Figure 10)	2	-	4	V	
Drain to Source On Resistance	r _{DS(ON)}	I _D = 43A, V _{GS} = 10V (Figure 9)	-	0.035	0.042	Ω	
THERMAL SPECIFICATIONS							
Thermal Resistance Junction to Case	R _{θJC}	TO-220, TO-263	-	-	0.65	⁰ C/W	
Thermal Resistance Junction to Ambient	R _{θJA}		-	-	62	⁰ C/W	
SWITCHING SPECIFICATIONS (V _{GS} = 10V)							
Turn-On Time	t _{ON}	V _{DD} = 75V, I _D = 43A V _{GS} = 10V, R _{GS} = 3.9Ω (Figures 18, 19)	-	-	100	ns	
Turn-On Delay Time	t _{d(ON)}		-	13	-	ns	
Rise Time	t _r		-	53	-	ns	
Turn-Off Delay Time	t _{d(OFF)}		-	47	-	ns	
Fall Time	t _f		-	34	-	ns	
Turn-Off Time	t _{OFF}		-	-	120	ns	
GATE CHARGE SPECIFICATIONS							
Total Gate Charge	Q _{g(TOT)}	V _{GS} = 0V to 20V	V _{DD} = 75V, I _D = 43A, I _{g(REF)} = 1.0mA (Figures 13, 16, 17)	-	144	175	nC
Gate Charge at 10V	Q _{g(10)}	V _{GS} = 0V to 10V		-	77	90	nC
Threshold Gate Charge	Q _{g(TH)}	V _{GS} = 0V to 2V		-	5.6	6.7	nC
Gate to Source Gate Charge	Q _{gs}			-	12	-	nC
Gate to Drain "Miller" Charge	Q _{gd}			-	30	-	nC
CAPACITANCE SPECIFICATIONS							
Input Capacitance	C _{ISS}	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz (Figure 12)	-	2730	-	pF	
Output Capacitance	C _{OSS}		-	660	-	pF	
Reverse Transfer Capacitance	C _{RSS}		-	230	-	pF	

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage	V_{SD}	$I_{SD} = 43\text{A}$	-	-	1.25	V
		$I_{SD} = 22\text{A}$	-	-	1.00	V
Reverse Recovery Time	t_{rr}	$I_{SD} = 43\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	190	ns
Reverse Recovered Charge	Q_{RR}	$I_{SD} = 43\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	1.08	μC

Typical Performance Curves

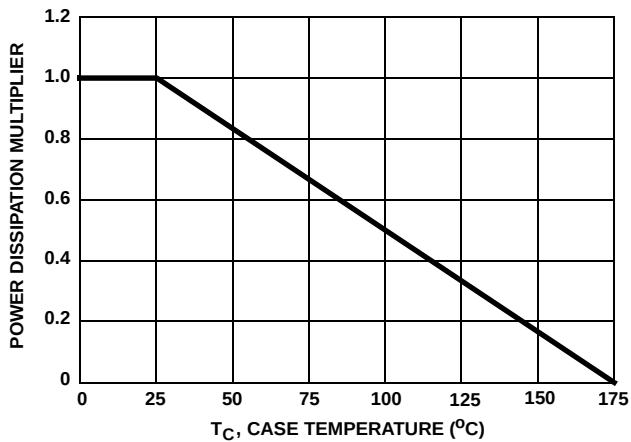


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

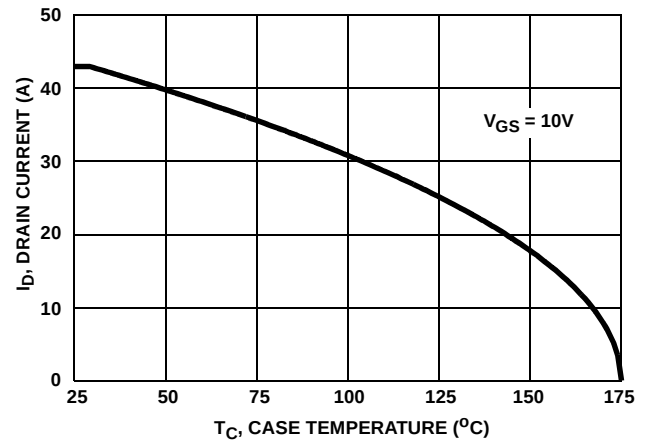


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

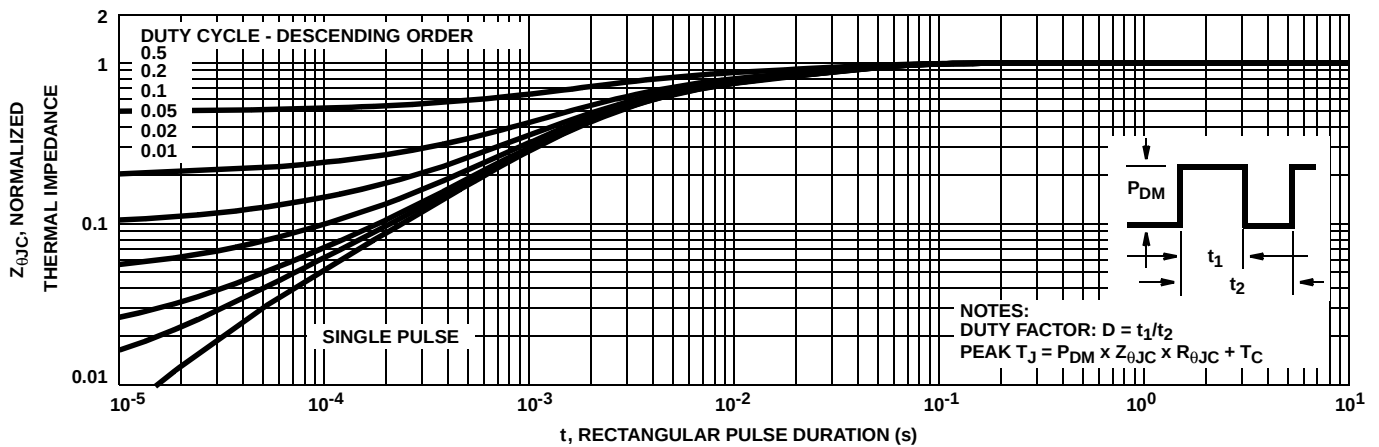


FIGURE 3. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

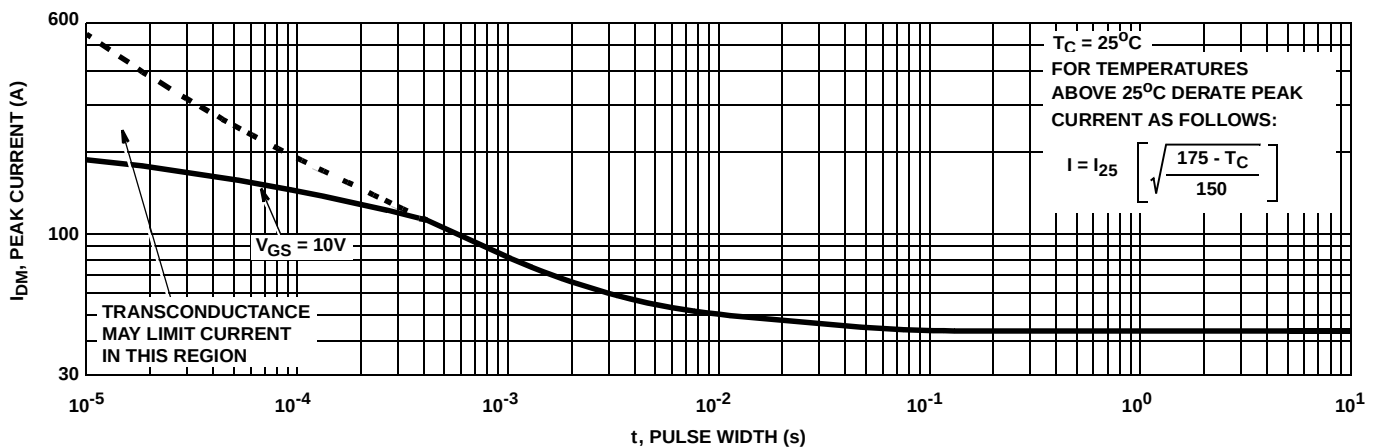


FIGURE 4. PEAK CURRENT CAPABILITY

Typical Performance Curves (Continued)

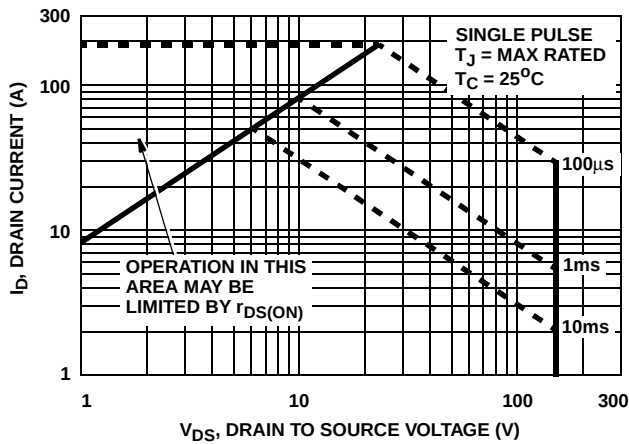
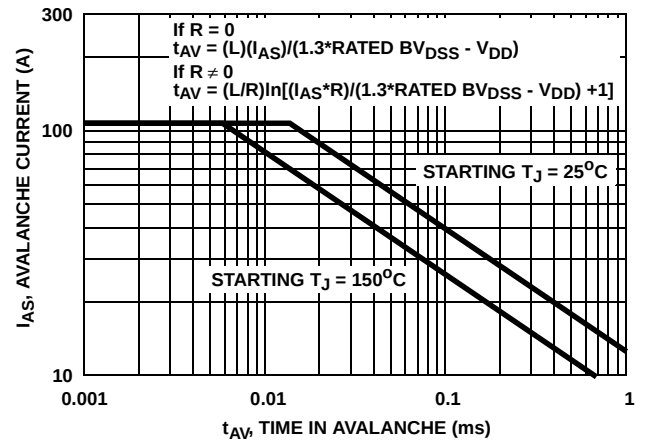


FIGURE 5. FORWARD BIAS SAFE OPERATING AREA



NOTE: Refer to Fairchild Application Notes AN9321 and AN9322.

FIGURE 6. UNCLAMPED INDUCTIVE SWITCHING CAPABILITY

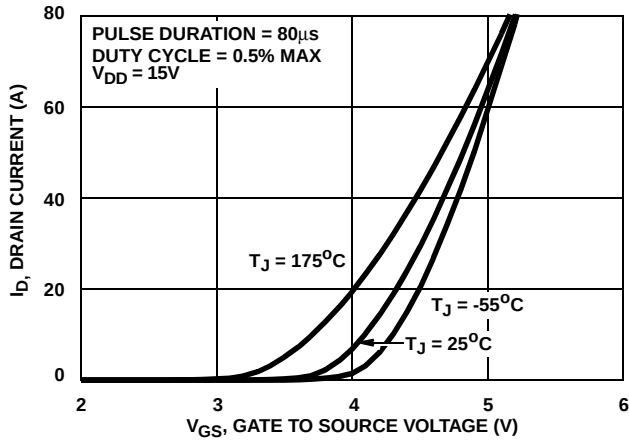


FIGURE 7. TRANSFER CHARACTERISTICS

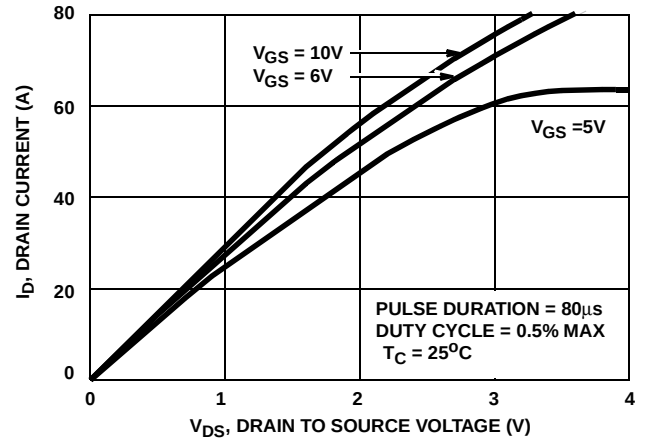


FIGURE 8. SATURATION CHARACTERISTICS

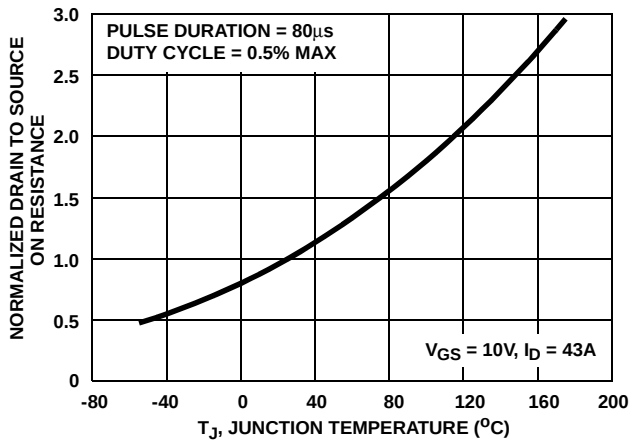


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

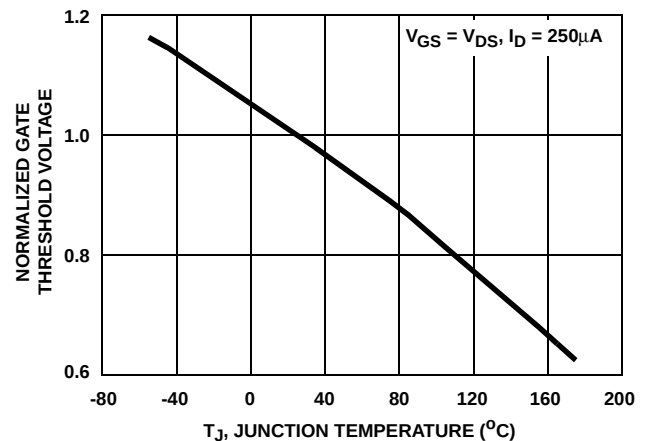


FIGURE 10. NORMALIZED GATE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE

Typical Performance Curves (Continued)

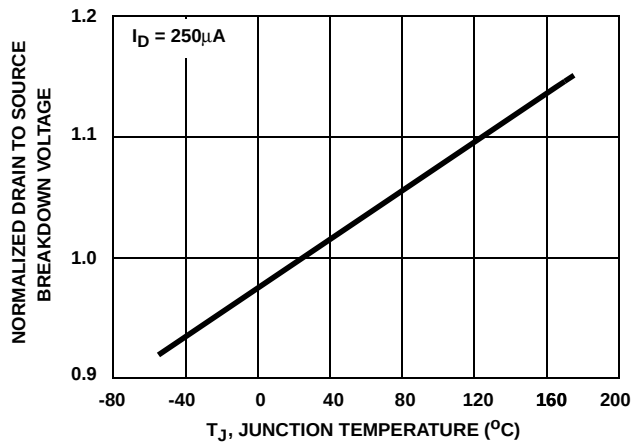


FIGURE 11. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

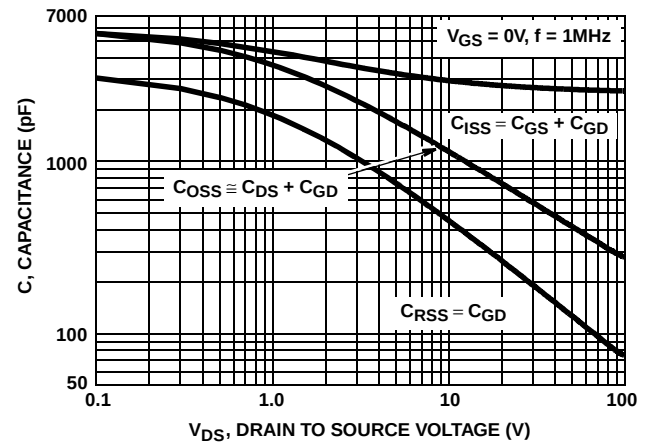
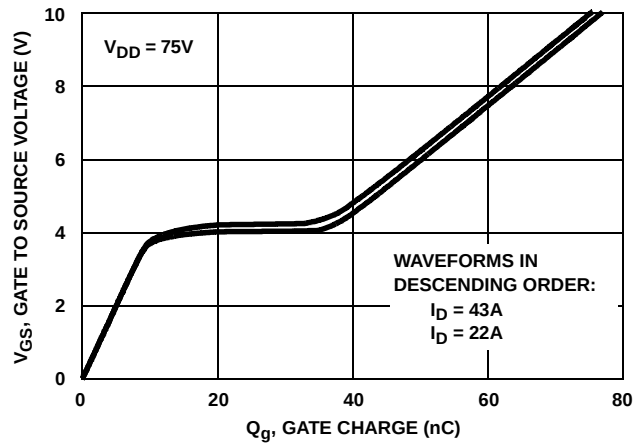


FIGURE 12. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE



NOTE: Refer to Fairchild Application Notes AN7254 and AN7260.

FIGURE 13. GATE CHARGE WAVEFORMS FOR CONSTANT GATE CURRENT

Test Circuits and Waveforms

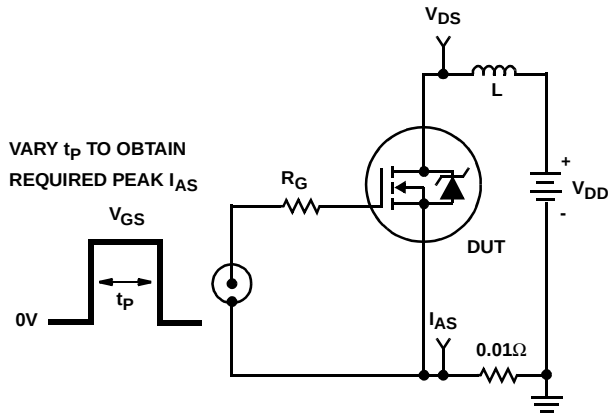


FIGURE 14. UNCLAMPED ENERGY TEST CIRCUIT

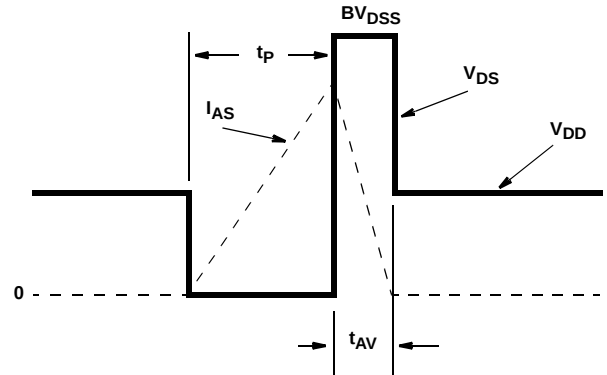


FIGURE 15. UNCLAMPED ENERGY WAVEFORMS

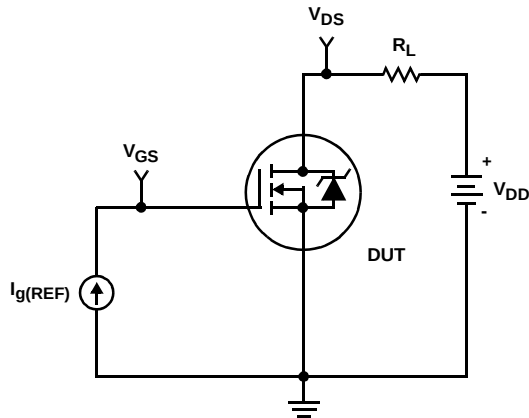


FIGURE 16. GATE CHARGE TEST CIRCUIT

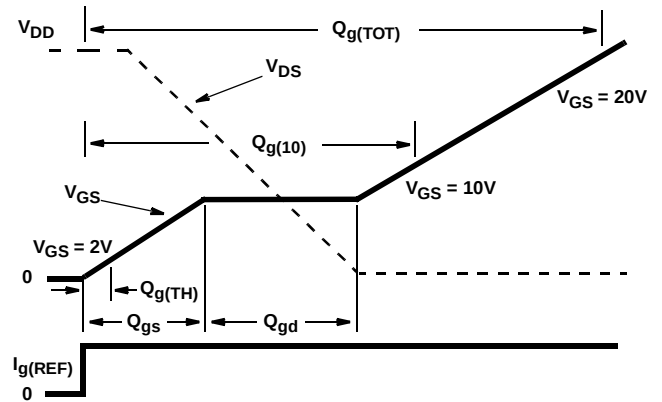


FIGURE 17. GATE CHARGE WAVEFORMS

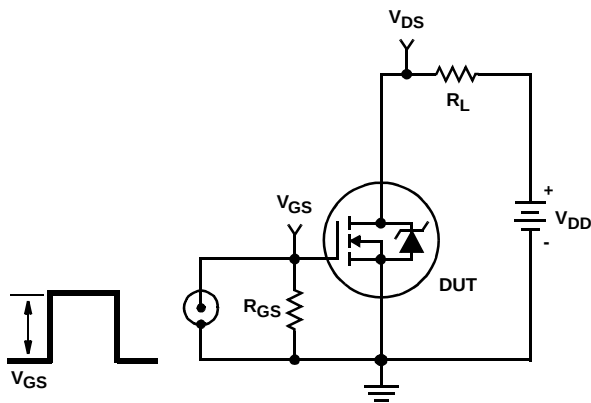


FIGURE 18. SWITCHING TIME TEST CIRCUIT

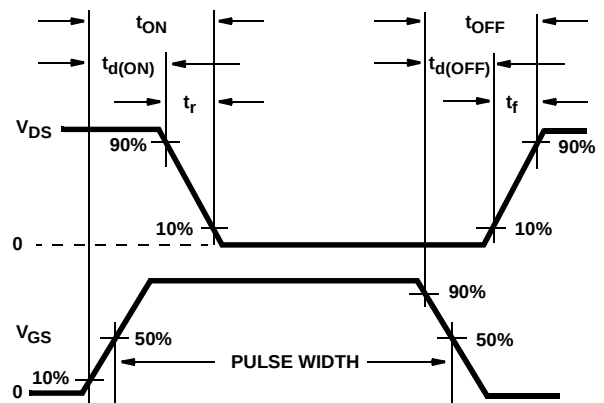


FIGURE 19. SWITCHING TIME WAVEFORM

PSPICE Electrical Model

.SUBCKT HUF75842 2 1 3 ; rev 13 October 1999

CA 12 8 4.10e-9
CB 15 14 4.10e-9
CIN 6 8 2.50e-9

DBODY 7 5 DBODYMOD
DBREAK 5 11 DBREAKMOD
DPLCAP 10 5 DPLCAPMOD

EBREAK 11 7 17 18 157.5
EDS 14 8 5 8 1
EGS 13 8 6 8 1
ESG 6 10 6 8 1
EVTHRES 6 21 19 8 1
EVTEMP 20 6 18 22 1

IT 8 17 1

LDRAIN 2 5 1.0e-9
LGATE 1 9 4.86e-9
LSOURCE 3 7 2.01e-9

MMED 16 6 8 8 MMEDMOD
MSTRO 16 6 8 8 MSTROMOD
MWEAK 16 21 8 8 MWEAKMOD

RBREAK 17 18 RBREAKMOD 1
RDRAIN 50 16 RDRAINMOD 2.72e-2
RGATE 9 20 0.73
RLDRAIN 2 5 10
RLGATE 1 9 48.6
RLSOURCE 3 7 20.1
RSLC1 5 51 RSLCMOD 1e-6
RSLC2 5 50 1e3
RSOURCE 8 7 RSOURCEMOD 3.58e-3
RVTHRES 22 8 RVTHRESMOD 1
RVTEMP 18 19 RVTEMPMOD 1

S1A 6 12 13 8 S1AMOD
S1B 13 12 13 8 S1BMOD
S2A 6 15 14 13 S2AMOD
S2B 13 15 14 13 S2BMOD

VBAT 22 19 DC 1

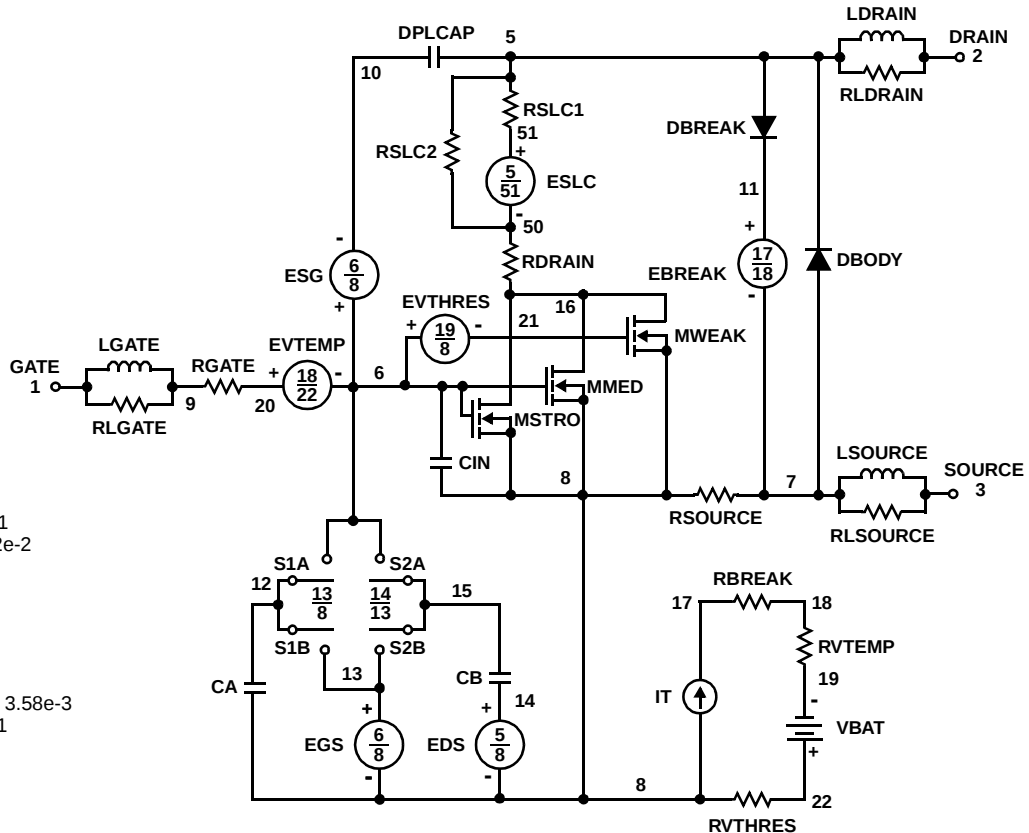
ESLC 51 50 VALUE={ (V(5,51)/ABS(V(5,51))) * (PWR(V(5,51)/(1e-6*88), 3.5)) }

.MODEL DBODYMOD D (IS = 2.25e-12 RS = 2.45e-3 IFK=14 XTI = 5 TRS1 = 2.7e-3 TRS2 = 0 CJO = 2.60e-9 TT = 1.22e-7 M = 0.55)
.MODEL DBREAKMOD D (RS = 6.50e-1 TRS1 = 1e-3 TRS2 = 1e-6)
.MODEL DPLCAPMOD D (CJO = 3.30e-9 IS = 1e-3 OM = 0.82)
.MODEL MMEDMOD NMOS (VTO = 3.20 KP = 6 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 0.73)
.MODEL MSTROMOD NMOS (VTO = 3.63 KP = 86 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u)
.MODEL MWEAKMOD NMOS (VTO = 2.78 KP = 0.10 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 7.30)
.MODEL RBREAKMOD RES (TC1 = 1.02e-3 TC2 = 0)
.MODEL RDRAINMOD RES (TC1 = 9.40e-3 TC2 = 2.70e-5)
.MODEL RSLCMOD RES (TC1 = 4.10e-3 TC2 = 4.00e-6)
.MODEL RSOURCEMOD RES (TC1 = 1e-3 TC2 = 1e-6)
.MODEL RVTHRESMOD RES (TC1 = -2.57e-3 TC2 = -7.05e-6)
.MODEL RVTEMPMOD RES (TC1 = -2.85e-3 TC2 = 9.00e-7)

.MODEL S1AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -5.8 VOFF = -2.4)
.MODEL S1BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -2.4 VOFF = -5.8)
.MODEL S2AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -1.8 VOFF = 0.5)
.MODEL S2BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 0.5 VOFF = -1.8)

.ENDS

NOTE: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.



SPICE Thermal Model

REV 13 October 1999

HUF75842T

CTHERM1 th 6 5.20e-3
 CTHERM2 6 5 2.40e-2
 CTHERM3 5 4 2.00e-2
 CTHERM4 4 3 1.80e-2
 CTHERM5 3 2 2.40e-2
 CTHERM6 2 tl 1.80e-1

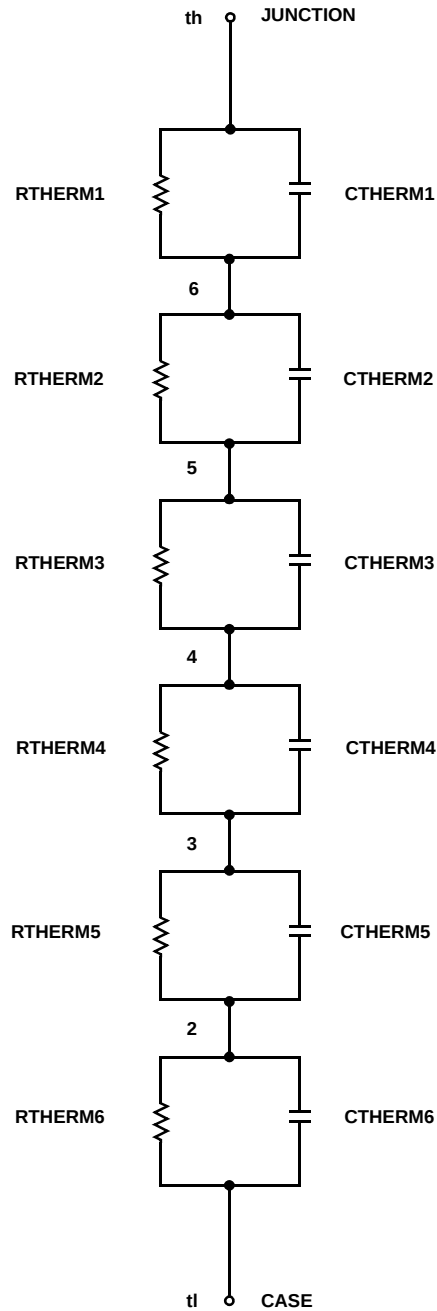
R THERM1 th 6 1.00e-2
 R THERM2 6 5 2.00e-2
 R THERM3 5 4 6.40e-2
 R THERM4 4 3 1.00e-1
 R THERM5 3 2 1.56e-1
 R THERM6 2 tl 1.65e-1

SABER Thermal Model

SABER thermal model HUF75842T

```
template thermal_model th tl
thermal_c th, tl
{
    ctherm.ctherm1 th 6 = 5.20e-3
    ctherm.ctherm2 6 5 = 2.40e-2
    ctherm.ctherm3 5 4 = 2.00e-2
    ctherm.ctherm4 4 3 = 1.80e-2
    ctherm.ctherm5 3 2 = 2.40e-2
    ctherm.ctherm6 2 tl = 1.80e-1

    rtherm.rtherm1 th 6 = 1.00e-2
    rtherm.rtherm2 6 5 = 2.00e-2
    rtherm.rtherm3 5 4 = 6.40e-2
    rtherm.rtherm4 4 3 = 1.00e-1
    rtherm.rtherm5 3 2 = 1.56e-1
    rtherm.rtherm6 2 tl = 1.65e-1
}
```



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